

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 03500.017784	APPLICATION NO. 10/728,825		
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			APPLICANT TAKASHI AWAI, ET AL.			
Submitted to the PTO: January 7, 2004			FILING DATE December 8, 2003	GROUP Unassigned <i>2625</i>		
JAN 07 2005 U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>CL</i>	5,391,009	02/21/1995	Stodder	400	605	
<i>CL</i>	5,903,365	05/11/1999	Iwata et al.	358	498	
<i>GL</i>	6,181,894	01/30/2001	Kaneko et al.	399	82	
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER	<i>Cheukfan Lee</i>		DATE CONSIDERED	<i>9-27-07</i>		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1

LAS:eyw

DC_MAIN 154468v1



FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: September 3, 2004		ATTY DOCKET NO. 03500.017784.		APPLICATION NO. 10/728,825		
		APPLICANT Takashi AWAI et al.				
		FILING DATE December 8, 2003		GROUP 2625 Unassigned		
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
CL	5,391,009	02/21/1995	Stodder	400	605	
CL	US 2002/051665 A1	05/2/2002	Seto et al.	399	388	
	US 2002/051665 A1					
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
CL	EP 0 473 167	03/04/19922	EP			
CL	EP 0 839 664 A	05/06/1998	EP			
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
	Original copy of European Search Report dated June 30, 2004 (Application No. EP 03 02 9550)					
EXAMINER	<i>Cheukfan Lee</i>		DATE CONSIDERED		<i>9-27-07</i>	

communication to applicant.

Sheet 1 of 1

MJD/ksp

DC_MAIN 175500v1

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 03500.017784	JAN 10 2006		APPLICATION NO. 10/728,825	
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			APPLICANT TAKASHI AWAI ET AL				
Date submitted to PTO: January 10, 2006			FILING DATE December 8, 2003	GROUP 2621 2625			
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>CL</i>		5,966,158	10/1999	Ebata et al.	347	104	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER	<i>Cheuk-fan Lee</i>		DATE CONSIDERED			<i>9-27-07</i>	

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1

MJD:MAW:eyw

DC_MAIN 225620v1

FORM PTO 1449 (<i>modified</i>) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. 03500.017784	APPLICATION NO. 10/728,825			
Date submitted to PTO: June 18, 2007			APPLICANT TAKASHI AWAI ET AL.				
			FILING DATE December 8, 2003	GROUP 2625			
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO OR ABSTRACT
<i>CL</i>		61-116645	07/1986	Japan			Yes
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER	<i>Cheukfan Lee</i>			DATE CONSIDERED	<i>9-27-07</i>		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1

AMM:eyw